

IDECAT WP3 Seminar

Prag

November 28, 2006

High pressure XPS: A tool for the investigation of
heterogeneous catalytic processes

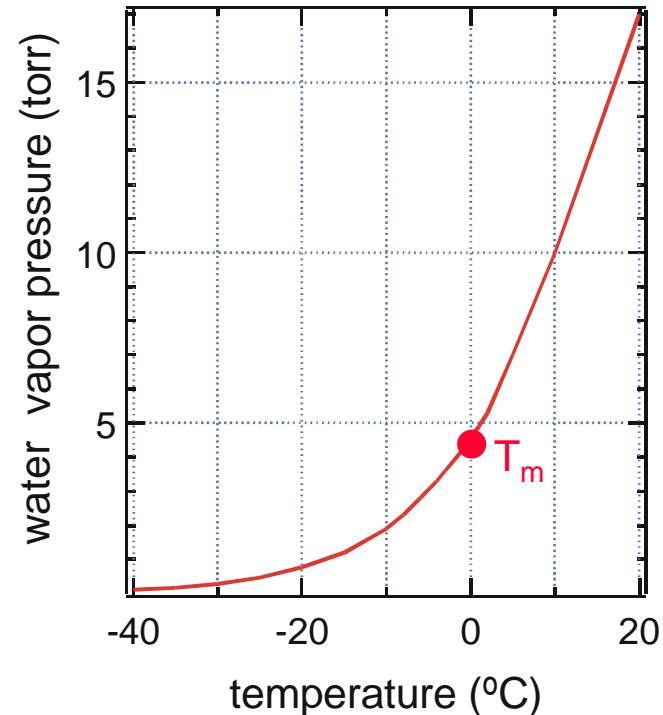
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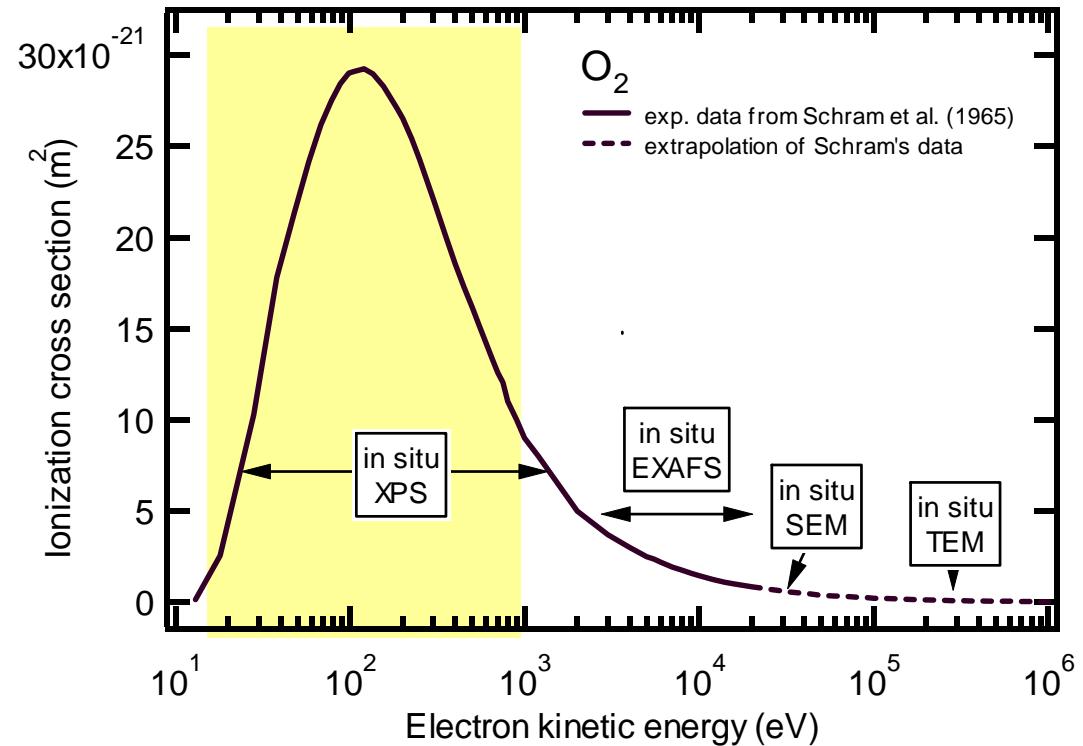
Why in situ XPS ?

- Many processes cannot be investigated in UHV:
"Pressure Gap"
 - environmental chemistry
 - catalysis
 - corrosion
 - electrochemistry
 - biological samples
- Very few methods can investigate the solid-gas interface at high pressures
 - non-linear optics (SFG, SHG)
 - scanning probe microscopies
 - X-ray diffraction
- Photoelectron spectroscopy is very powerful
⇒ Goal: XPS at pressures of at least 5 torr



In situ XPS: obstacles

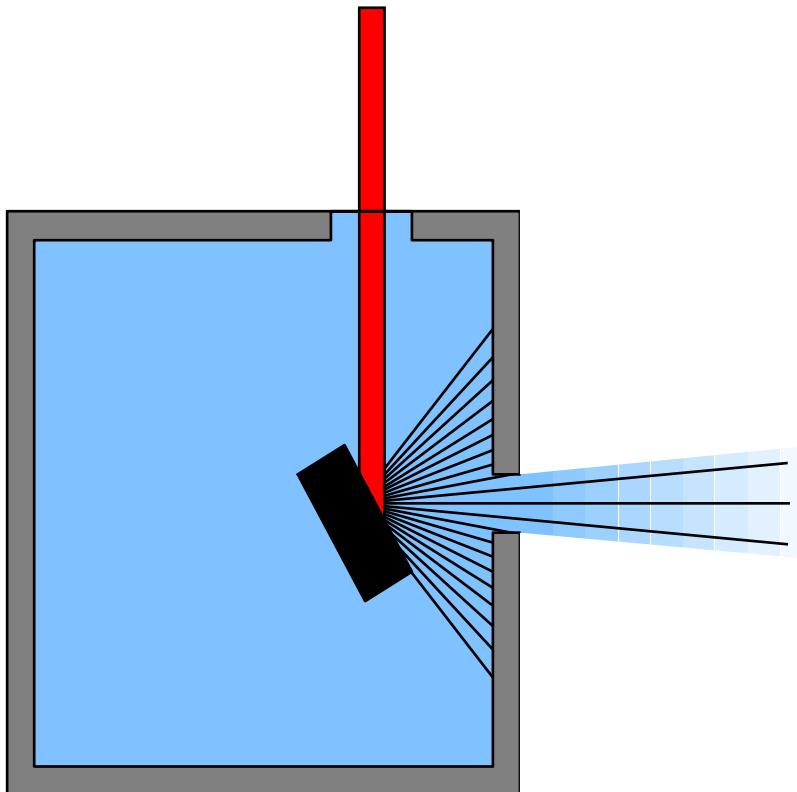
Fundamental limit:
elastic and inelastic
scattering of electrons
in the gas phase



Technical issues:

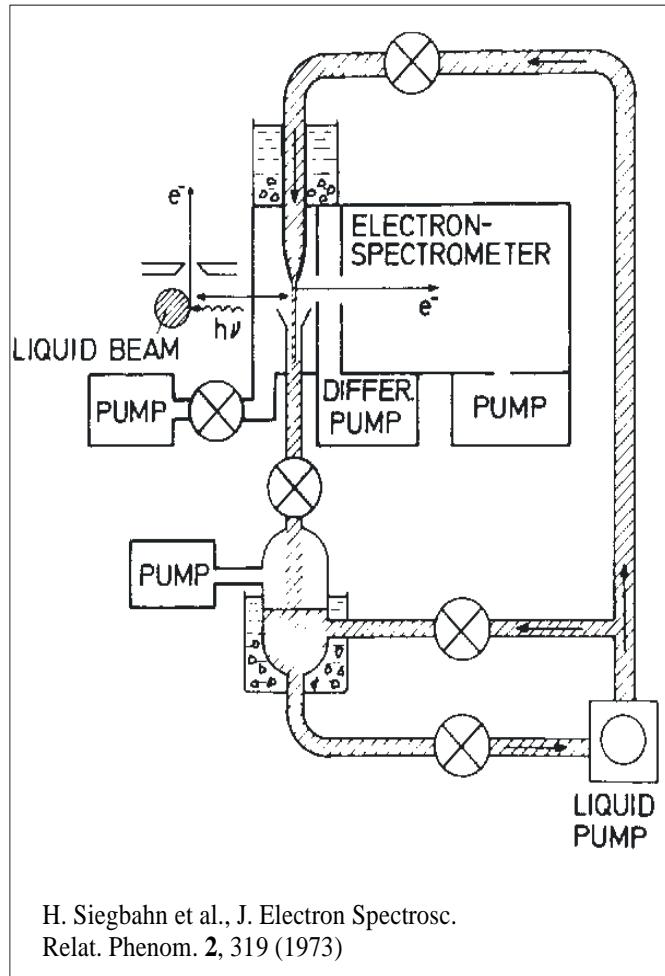
- Differential pumping to keep analyzer in high vacuum
- Sample preparation and control in a flow reactor

In situ XPS: basic concept

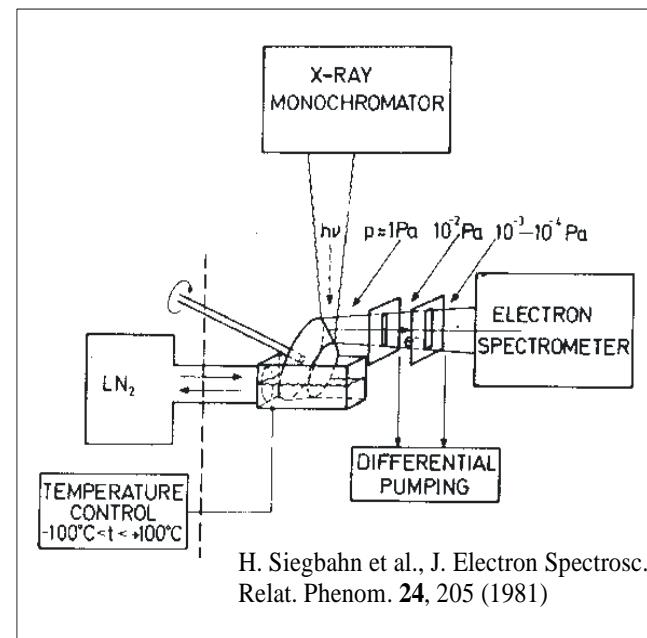


- Photons enter through a window
- Electrons and a gas jet escape through an aperture to vacuum

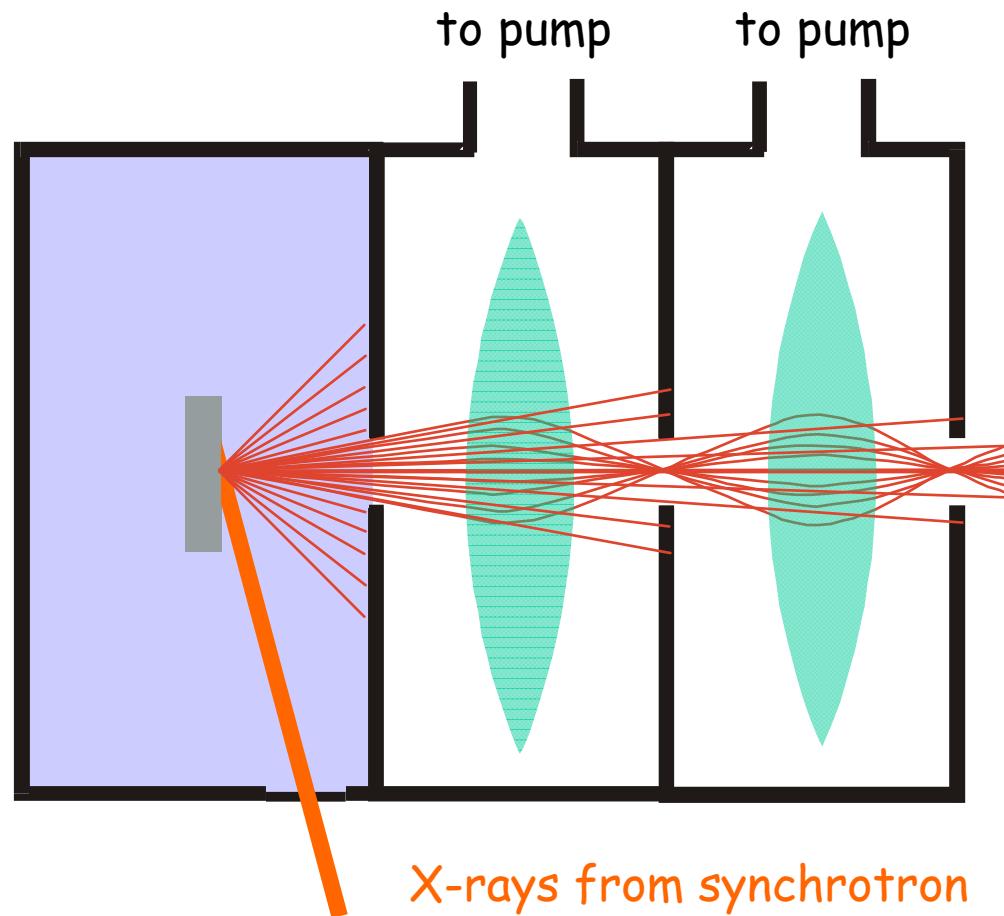
In situ XPS instruments: previous designs



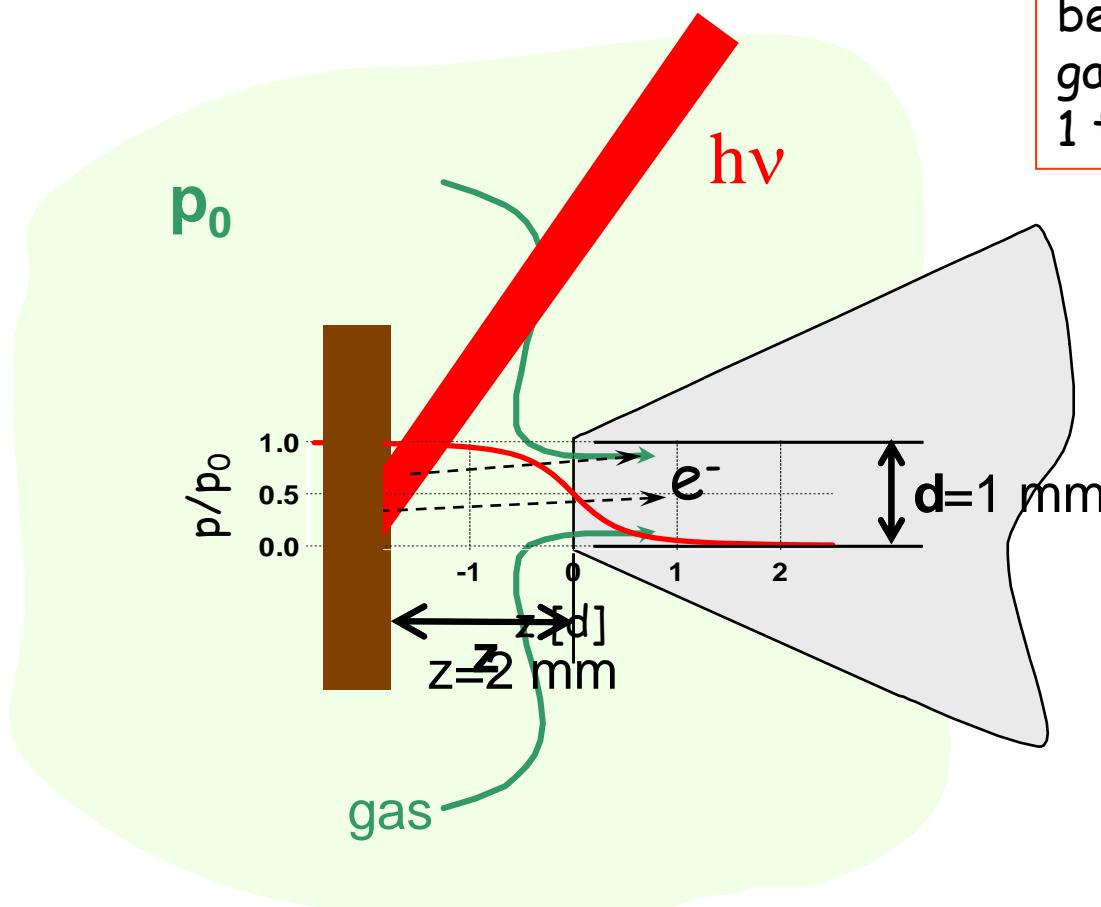
- H. Siegbahn et al. (1973-)
- M.W. Roberts et al. (1979)
- M. Faubel et al. (1987)
- M. Grunze et al. (1988)
- P. Oelhafen (1995)



In situ XPS using differentially pumped electrostatic lenses

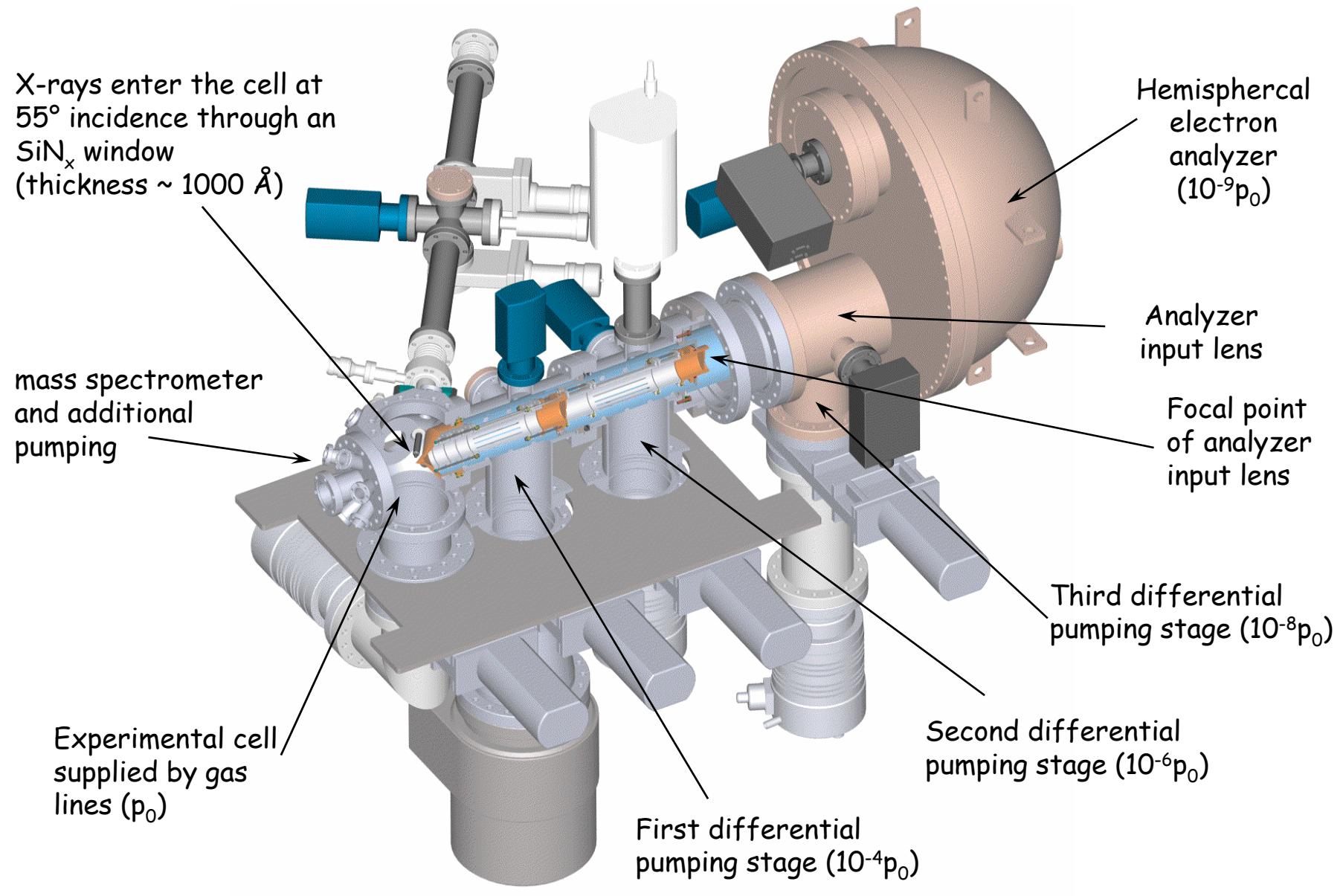


Close-up of sample-first aperture region

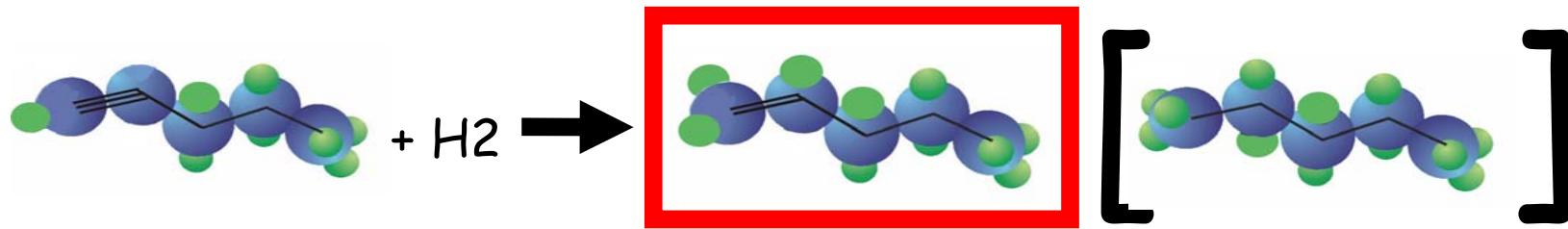


Gas phase composition can
be measured by XPS.
gas phase signal:
1 torr·mm ~ a few monolayers

In situ XPS system



Introduction



Literature

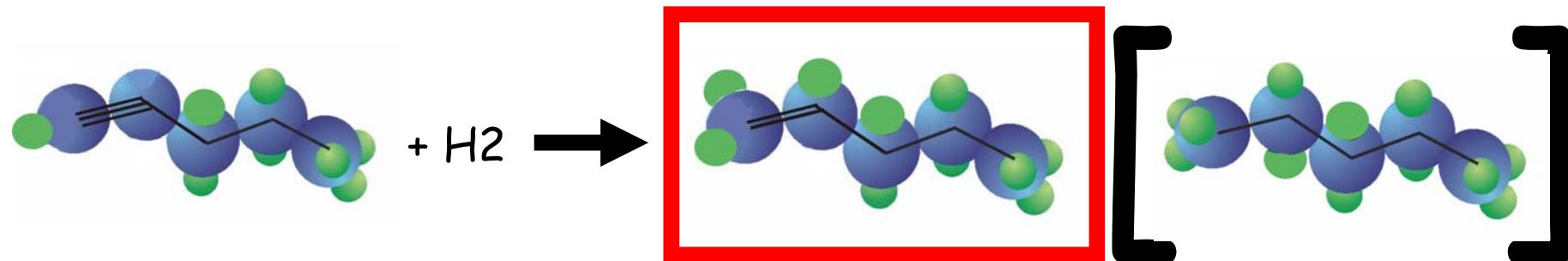
carbon laydown → selective hydrogenation
"similar" catalysts → different activity & selectivity
(structure sensitivity?)

Selectivity issue: what defines selectivity?

Summary

1. Subsurface H: effective for alkene-to-alkane but also for alkyne-to-alkane transformation
2. Surface H: could be selective (spillover)
3. Different reaction orders in the different selectivity regimes & Abrupt changes between regimes
4. C uptake is significantly more in the selective regime

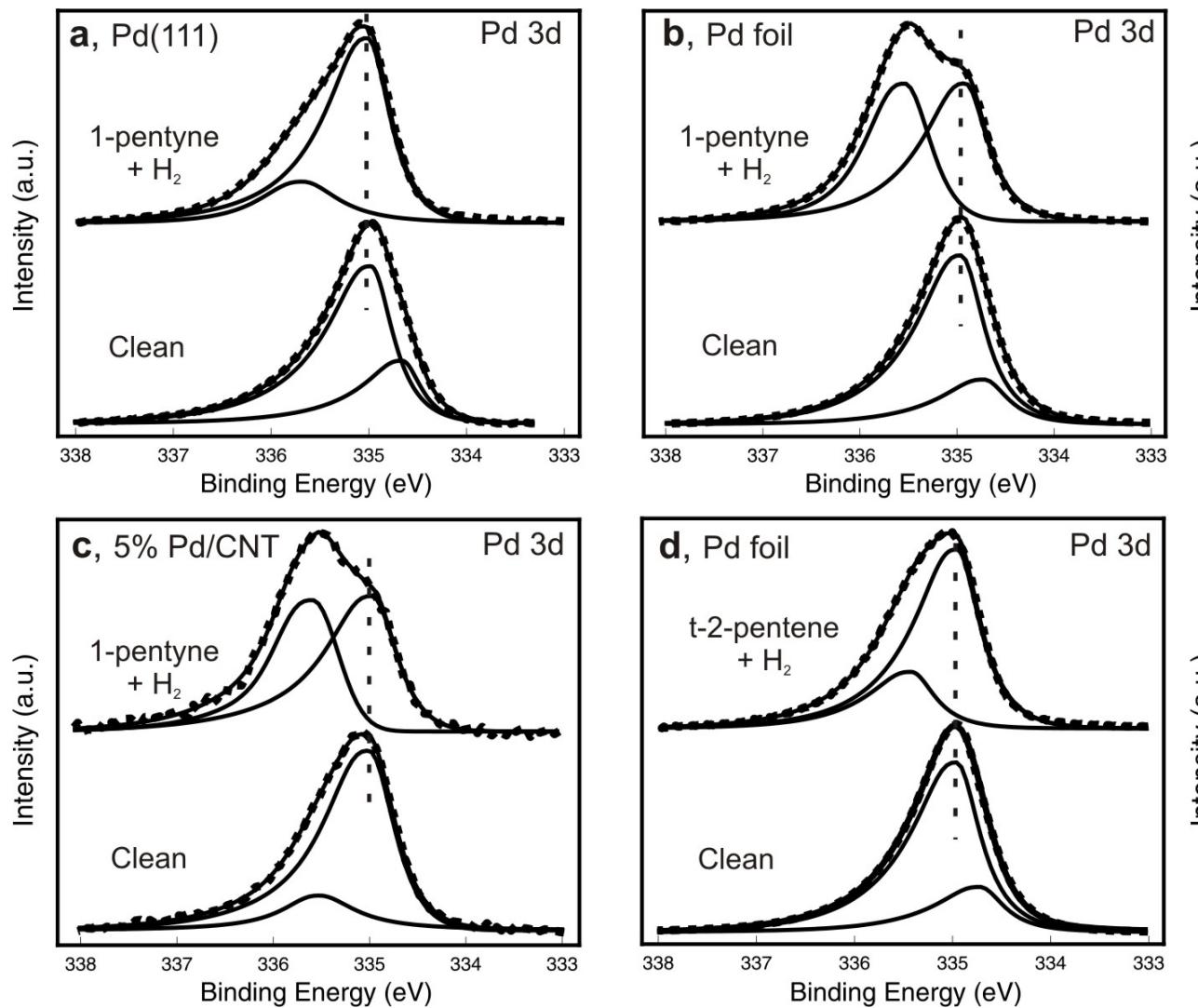
Reaction in the mbar p region (in-situ XPS)



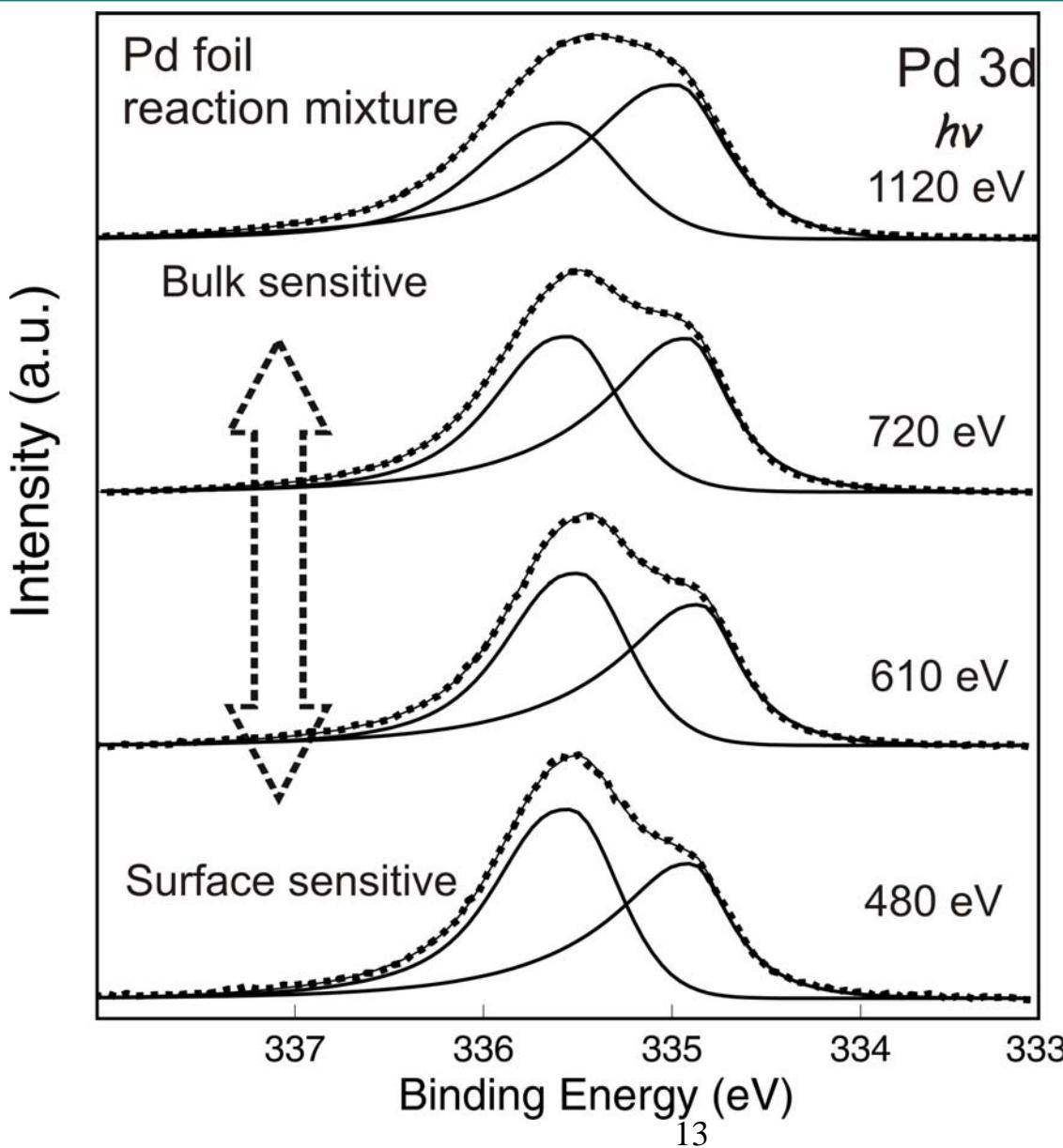
	5% Pd/CNT	3% Pd/Al ₂ O ₃	Pd foil	Pd(111)
Conversion [%]	~ 10	~5	~2.5	<1
Selectivity Pentene [%]	~95	~80	~98	100
Selectivity Pentane [%]	~5	~20	~2	-

Reaction conditions: C5/H₂ = 1:9, 1 mbar, 358 K

In-situ XPS: Pd 3d ($h\nu$: 720 eV)

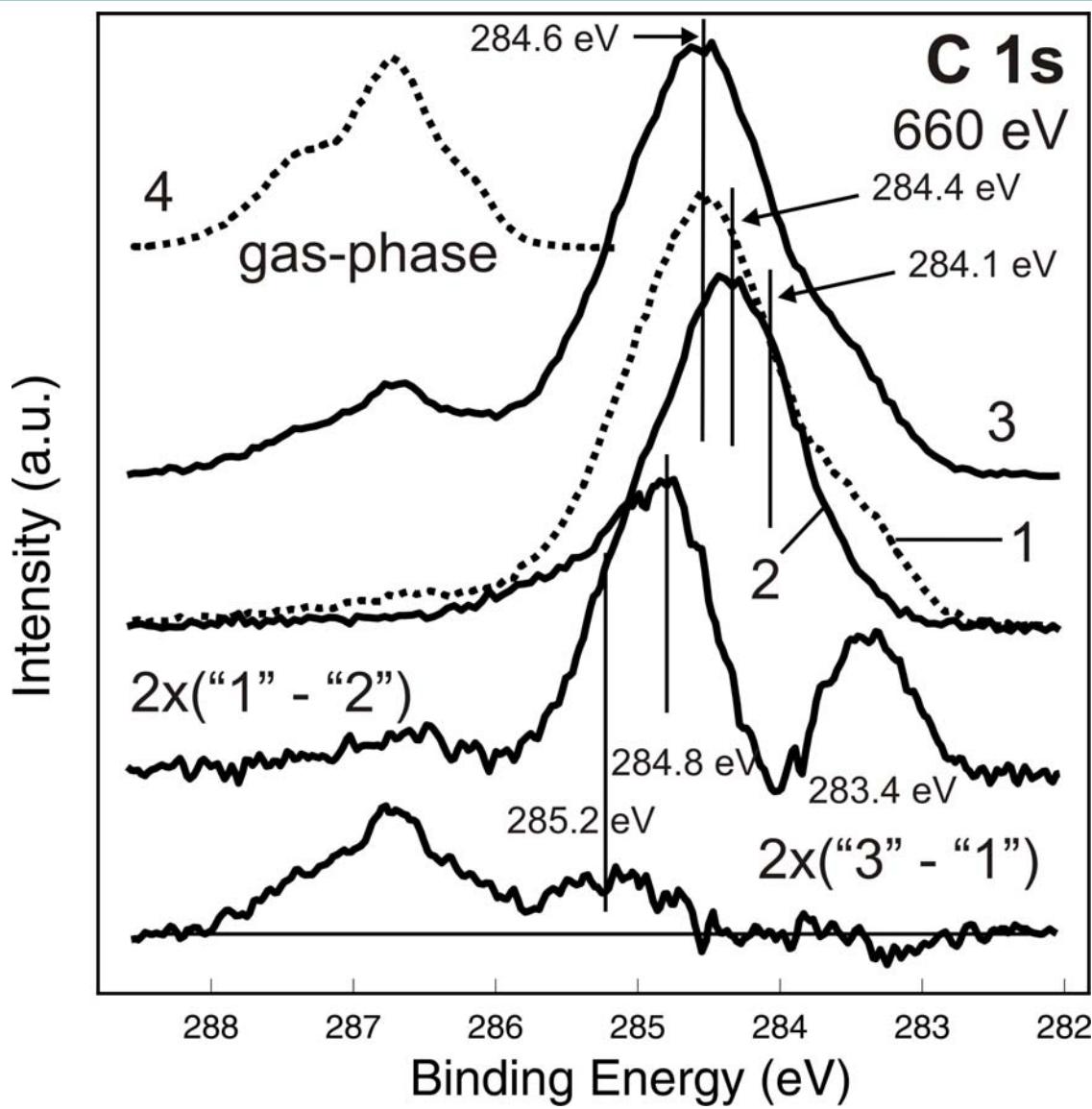


In-situ XPS: Pd 3d depth profiling



Not only
adsorbate-induced
surface core level
shift !
But on-top location!

In-situ XPS: C1s (Switching off experiments)

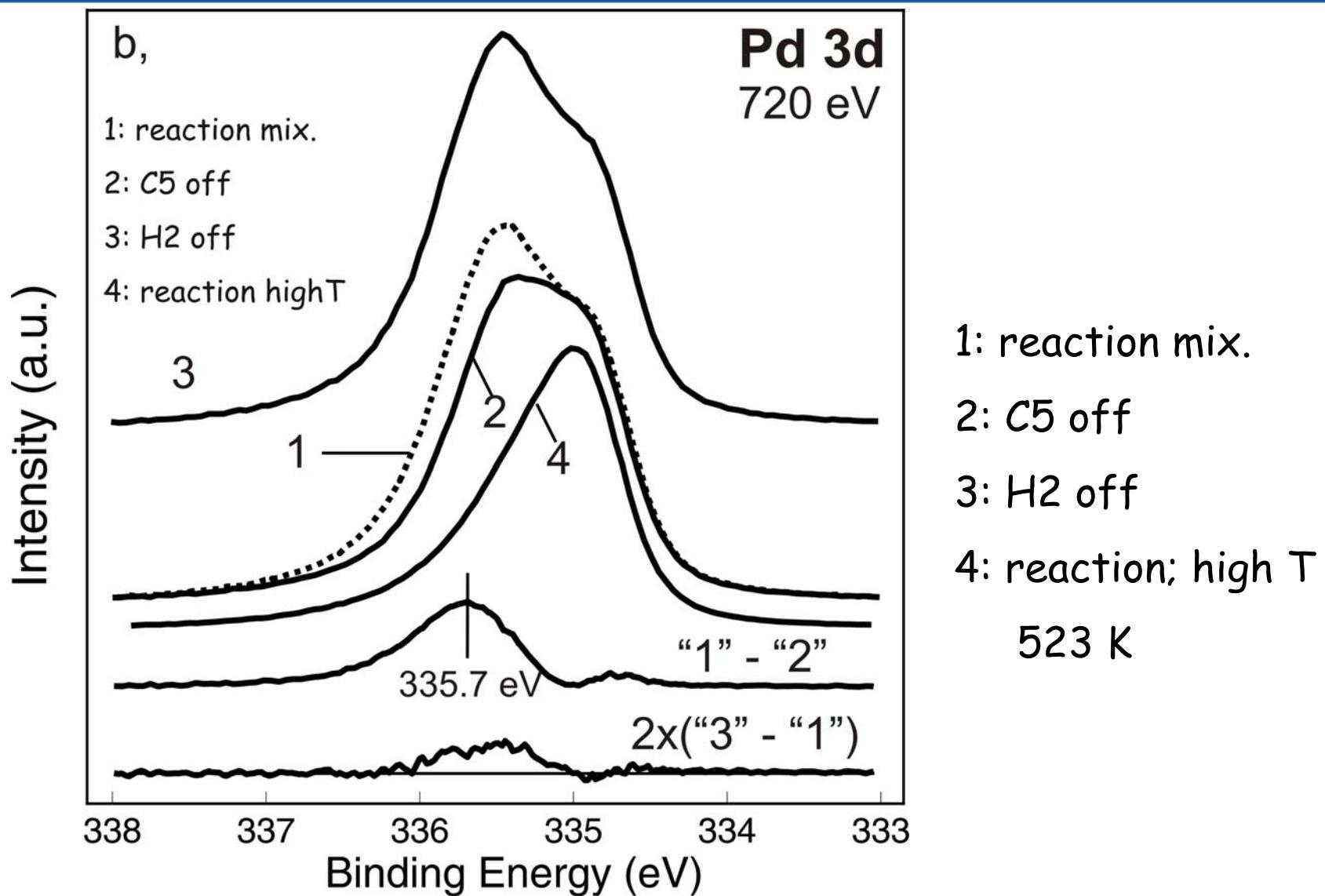


- 1: reaction mix.
- 2: C5 off
- 3: H2 off
- 4: C5 gas-phase

Teschner et al.

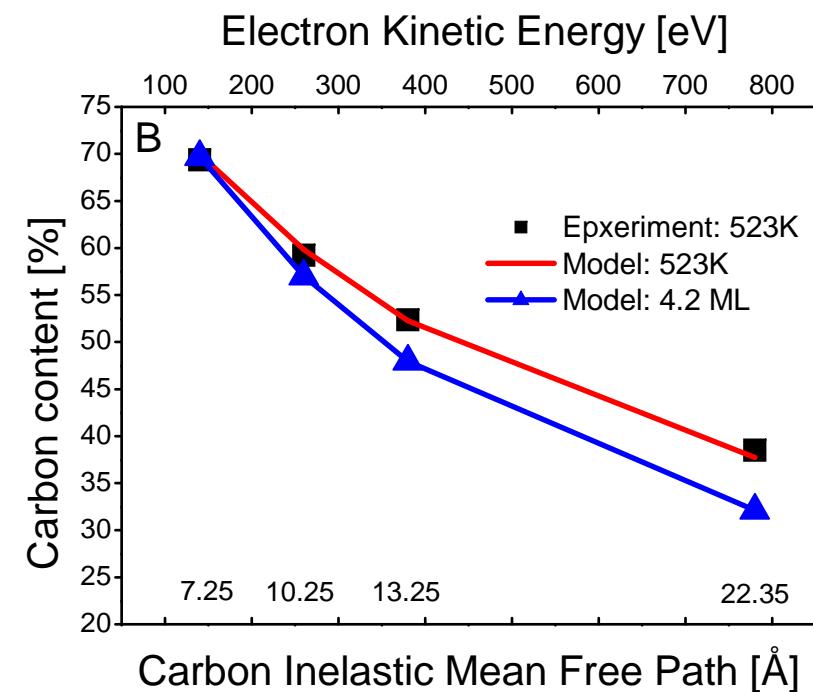
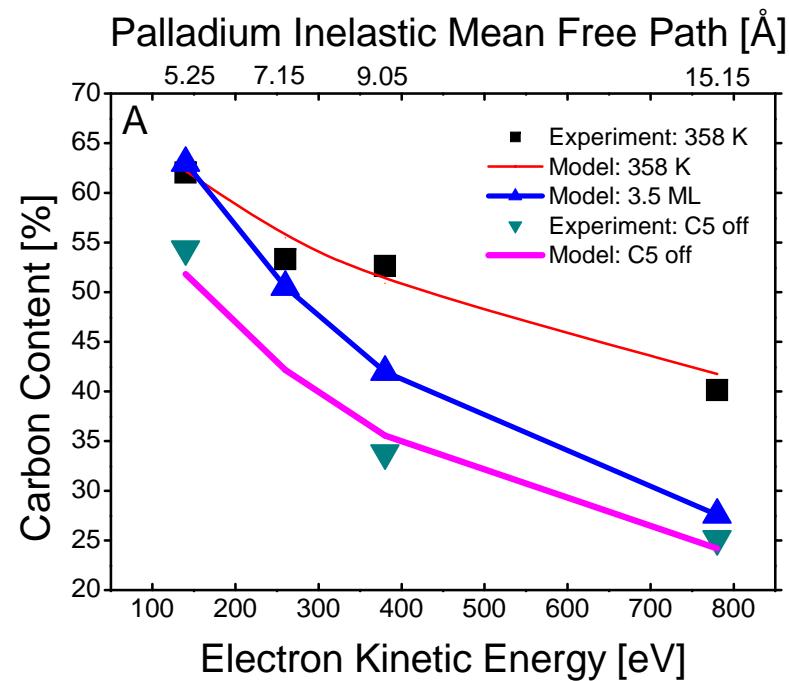
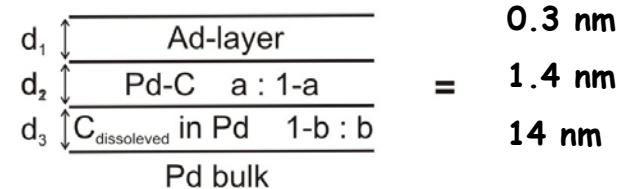
J. Catal. 242 (2006) 26-37

In-situ XPS: Pd 3d (Switching off experiments)



In-situ XPS: Pd vs. C depth profiling

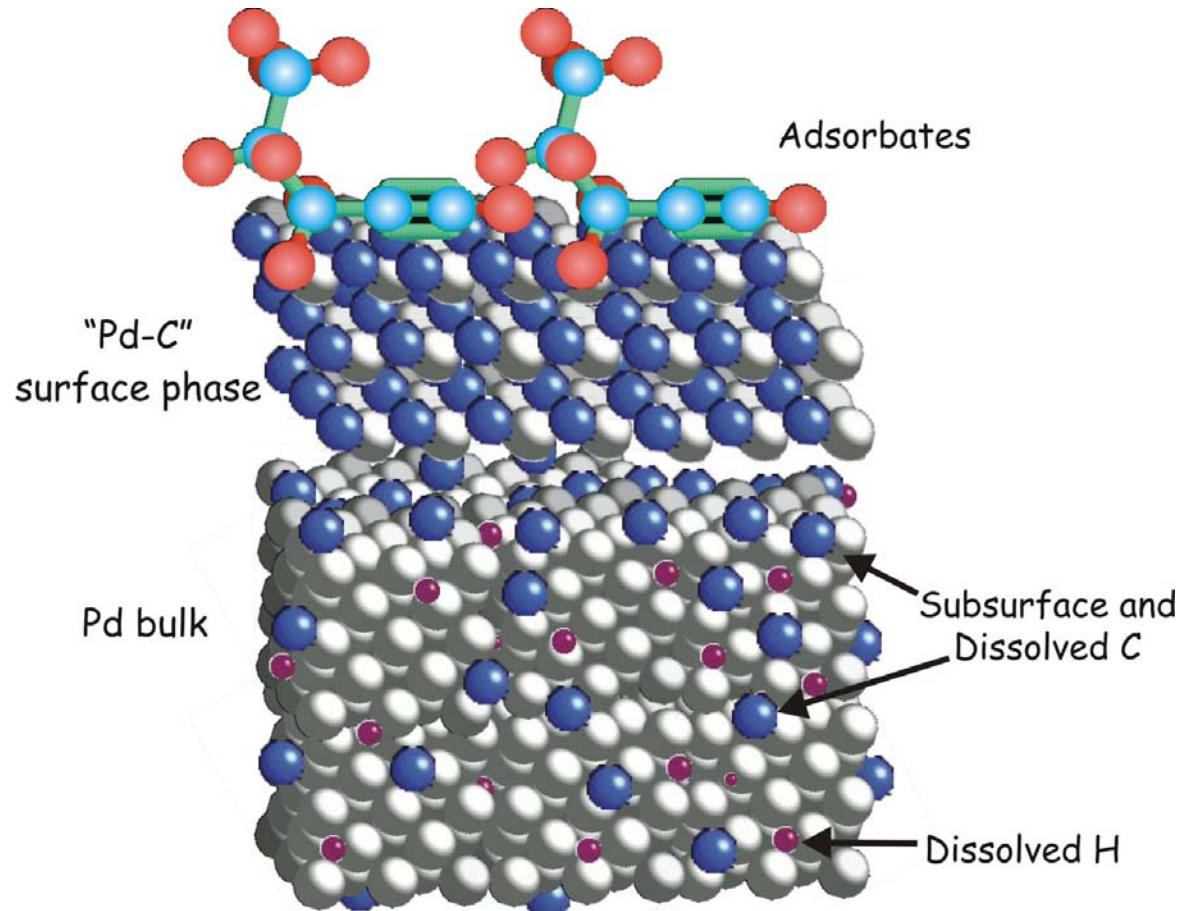
Model



Summary

1. Subsurface H: effective for alkene-to-alkane but also for alkyne-to-alkane transformation
2. Surface H: could be selective (spillover)
3. Different reaction orders in the different selectivity regimes & Abrupt changes between regimes
4. C uptake is considerably more in the selective regime
5. Pd-C surface phase forms in the early stage of selective pentyne hydrogenation & there is significant amount of subsurface C below of it

Model (during the reaction)



Summary

1. Subsurface H: effective for alkene-to-alkane but also for alkyne-to-alkane transformation
2. Surface H: could be selective (spillover)
3. Different reaction orders in the different selectivity regimes & Abrupt changes between regimes
4. C uptake is considerably more in the selective regime
5. Pd-C surface phase forms during selective hydrogenation of pentyne & there is significant amount of subsurface C below of it
6. Dynamic behaviour of Pd-C and subsurface C



MAX-PLANCK-GESELLSCHAFT

Outlook: In situ XPS / XAS The future at BESSY



ISISS:



Innovative Station for In Situ Spectroscopy

A project of BESSY and the Dep. Inorganic Chemistry, Fritz-Haber-Institut

- ▶ Installation of a beamline exclusively used for in situ spectroscopy in the soft X-ray range
- ▶ Installation of infrastructure optimized for these kind of experiments on site (e.g. chemical lab, gas supply, gas analytics)
- ▶ Later, further implementation of other in situ spectroscopy techniques: multi wavelength Raman, UV-Vis, fluorescence yield ?!
- ▶ Start of user operation of the beamline: 2007

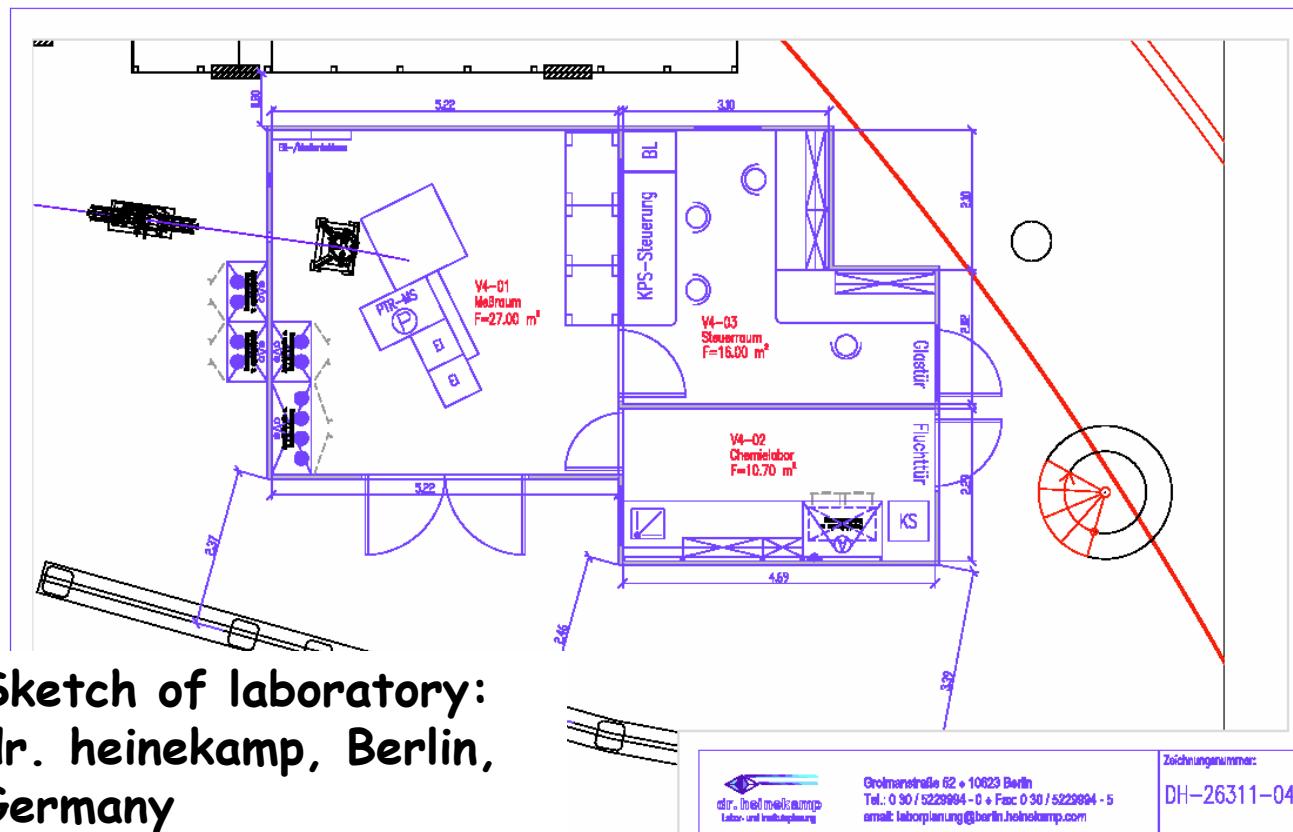


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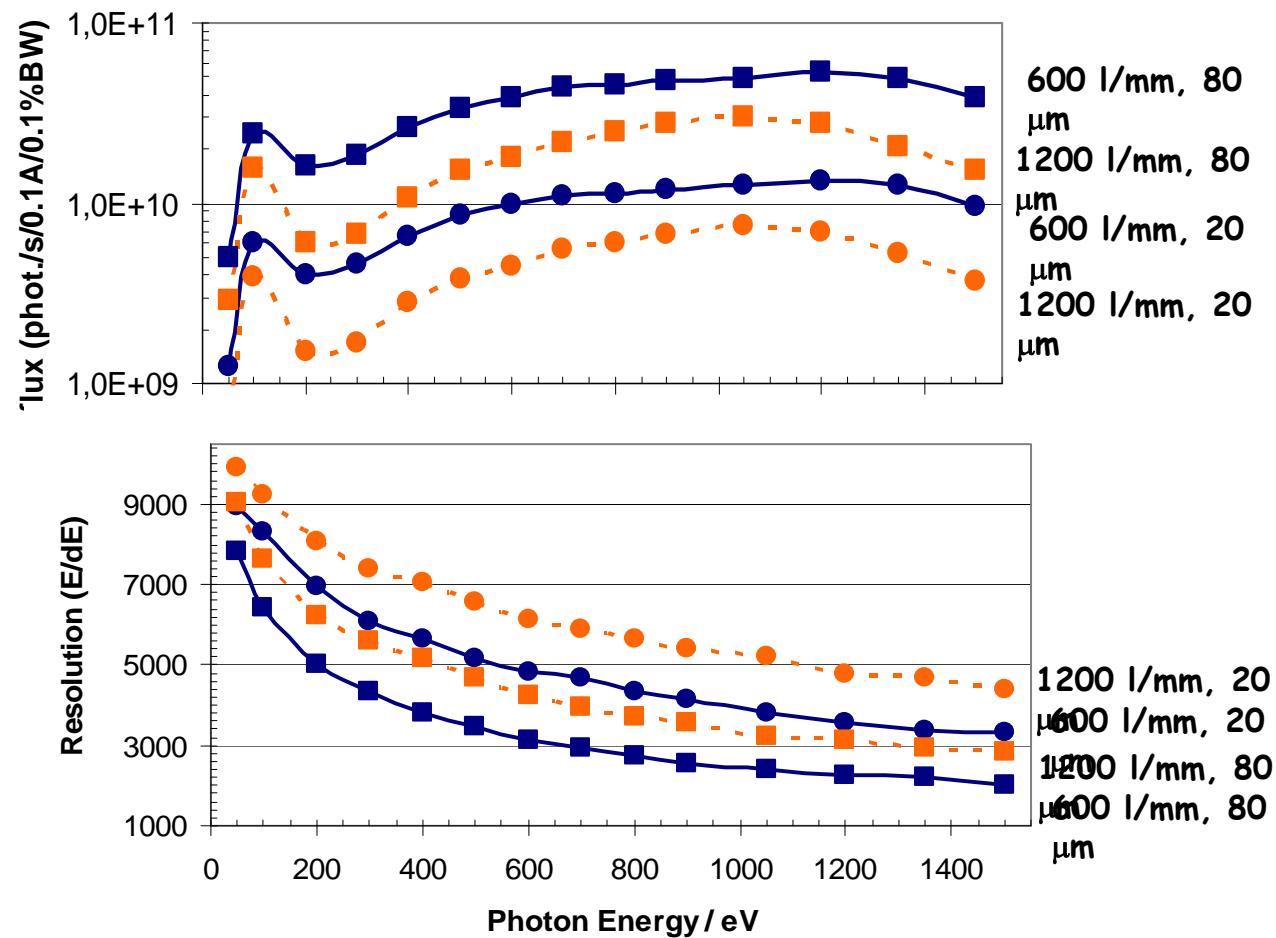


Sketch of laboratory:
dr. heinekamp, Berlin,
Germany



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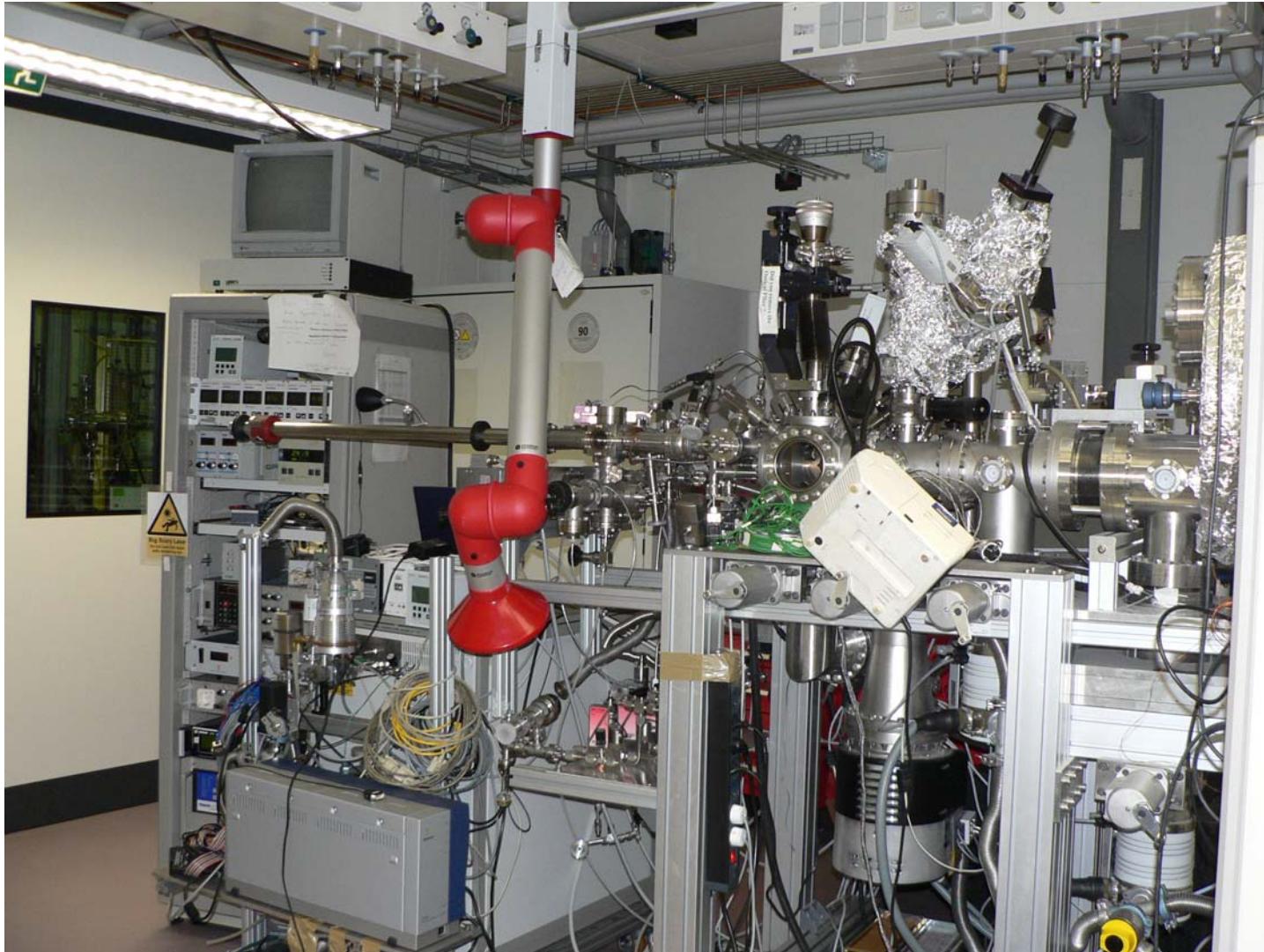
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